

Description

Semicoa Semiconductors offers:

- Screening and processing per MIL-PRF-19500 Appendix E
- JAN level (2N5038J)
- JANTX level (2N5038JX)
- JANTXV level (2N5038JV)
- QCI to the applicable level
- 100% die visual inspection per MIL-STD-750 method 2072 for JANTXV
- Radiation testing (total dose) upon request

Applications

- High-speed power-switching
- High power
- NPN silicon transistor



Features

- Hermetically sealed TO-3 metal can
- Also available in chip configuration
- Chip geometry 9351
- Reference document: MIL-PRF-19500/439

Benefits

- Qualification Levels: JAN, JANTX, and JANTXV
- Radiation testing available

Absolute Maximum Ratings		$T_c = 25^\circ\text{C}$ unless otherwise specified	
Parameter	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	90	Volts
Collector-Base Voltage	V_{CBO}	150	Volts
Emitter-Base Voltage	V_{EBO}	7	Volts
Collector Current, Continuous	I_C	20	A
Power Dissipation, $T_A = 25^\circ\text{C}$ Derate linearly above 25°C	P_T	140 800	W mW/ $^\circ\text{C}$
Thermal Resistance	R_{QJA}	1.25	$^\circ\text{C}/\text{W}$
Operating Junction Temperature	T_J	-65 to +200	$^\circ\text{C}$
Storage Temperature	T_{STG}	-65 to +200	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS

 characteristics specified at $T_A = 25^\circ\text{C}$
Off Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Collector-Emitter Breakdown Voltage	$V_{(\text{BR})\text{CEO}}$	$I_C = 200 \text{ mA}$	90			Volts
Emitter-Base Breakdown Voltage	$V_{(\text{BR})\text{EBO}}$	$I_E = 25 \text{ mA}$	7			Volts
Collector-Base Cutoff Current	I_{CBO1}	$V_{\text{CB}} = 150 \text{ Volts}$			1	μA
Collector-Emitter Cutoff Current	I_{CEO}	$V_{\text{CE}} = 70 \text{ Volts}$			1	μA
Collector-Emitter Cutoff Current	I_{CEX1} I_{CEX2}	$V_{\text{CE}} = 100 \text{ Volts}, V_{\text{EB}} = 1.5 \text{ Volts}$ $V_{\text{CE}} = 100 \text{ Volts}, V_{\text{EB}} = 1.5 \text{ Volts}, T_A = 150^\circ\text{C}$			5 100	μA
Emitter-Base Cutoff Current	I_{EBO}	$V_{\text{EB}} = 5 \text{ Volts}$			1	μA

On Characteristics

 Pulse Test: Pulse Width = 300 μs , Duty Cycle $\leq 2.0\%$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
DC Current Gain	$h_{\text{FE}1}$ $h_{\text{FE}2}$ $h_{\text{FE}3}$ $h_{\text{FE}4}$	$I_C = 0.5 \text{ A}, V_{\text{CE}} = 5 \text{ Volts}$ $I_C = 2 \text{ A}, V_{\text{CE}} = 5 \text{ Volts}$ $I_C = 12 \text{ A}, V_{\text{CE}} = 5 \text{ Volts}$ $I_C = 12 \text{ A}, V_{\text{CE}} = 5 \text{ Volts}$ $T_A = -55^\circ\text{C}$	50 50 15 10		200	
Base-Emitter Voltage	V_{BE}	$V_{\text{CE}} = 5 \text{ Volts}, I_C = 12 \text{ A}$			1.8	Volts
Base-Emitter Saturation Voltage	V_{BEsat}	$I_C = 20 \text{ A}, I_B = 5 \text{ A}$			3.3	Volts
Collector-Emitter Saturation Voltage	V_{CEsat1} V_{CEsat2}	$I_C = 12 \text{ A}, I_B = 1.2 \text{ A}$ $I_C = 20 \text{ A}, I_B = 5 \text{ A}$			1.0 2.5	Volts

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Magnitude – Common Emitter, Short Circuit Forward Current Transfer Ratio	$ h_{\text{FE}} $	$V_{\text{CE}} = 10 \text{ Volts}, I_C = 2 \text{ A}, f = 5 \text{ MHz}$	12		48	
Open Circuit Output Capacitance	C_{OBO}	$V_{\text{CB}} = 10 \text{ Volts}, I_E = 0 \text{ mA}, 100 \text{ kHz} < f < 1 \text{ MHz}$			500	pF

Switching Characteristics

Saturated Turn-On Time	t_{ON}	$I_C = 12 \text{ A}, I_{B1} = 1.2 \text{ A}$			0.5	μs
Saturated Turn-Off Time	t_{OFF}	$I_C = 12 \text{ A}, I_{B1} = -I_{B2} = 1.2 \text{ A}$			2.0	μs